

### FEATURES

- 2 independent channels optimized for photodiode interfacing
- 6-decade input dynamic range
- Law conformance 0.3 dB from 3 nA to 3 mA
- Temperature-stable logarithmic outputs
- Nominal slope 10 mV/dB (200 mV/dec), externally scalable
- Intercepts may be independently set by external resistors
- User-configurable output buffer amplifiers
- Single- or dual-supply operation
- Space-efficient, 24-lead 4 mm × 4 mm LFCSP
- Low power: < 10 mA quiescent current

### APPLICATIONS

- Gain and absorbance measurements
- Multichannel power monitoring
- General-purpose baseband log compression

### PRODUCT DESCRIPTION

The ADL5310<sup>1</sup> low cost, dual logarithmic amplifier converts input current over a wide dynamic range to a linear-in-dB output voltage. It is optimized to determine the optical power in wide-ranging optical communication system applications, including control circuitry for lasers, optical switches, attenuators, and amplifiers, as well as system monitoring. The device is equivalent to a dual AD8305 with enhanced dynamic range (120 dB). While the ADL5310 contains two independent signal channels with individually configurable transfer function constants (slope and intercept), internal bias circuitry is shared between channels for improved power consumption and channel matching. Dual converters in a single, compact LFCSP package yield space-efficient solutions for measuring gain or attenuation across optical elements. Only a single supply is required; optional dual-supply operation offers added flexibility.

The ADL5310 employs an optimized translinear structure that use the accurate logarithmic relationship between a bipolar transistor's base emitter voltage and collector current, with appropriate scaling by precision currents to compensate for the inherent temperature dependence. Input and reference current pins sink current ranging from 3 nA to 3 mA (limited to ±60 dB between input and reference) into a fixed voltage defined by the VSUM potential. The VSUM potential is internally set to 500 mV but may be externally grounded for dual-supply operation, and for additional applications requiring voltage inputs.

#### Rev. A

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### FUNCTIONAL BLOCK DIAGRAM

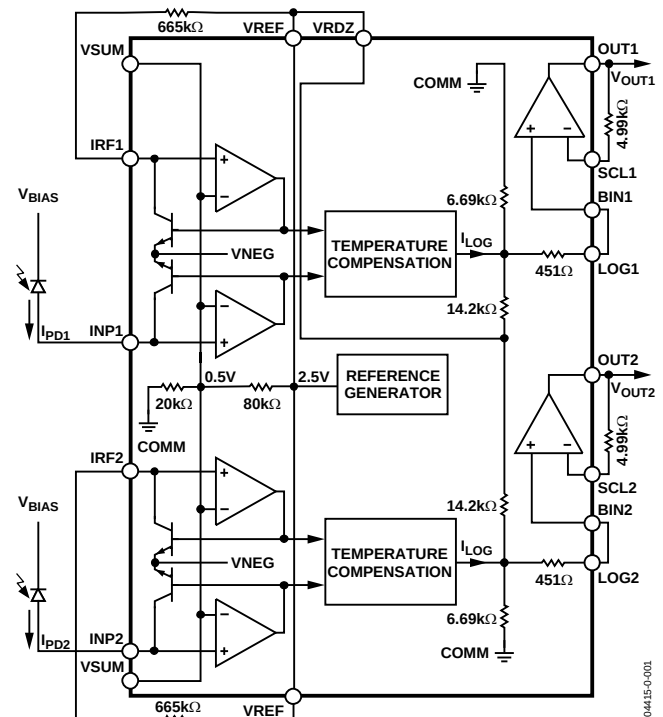


Figure 1.

The logarithmic slope is set to 10 mV/dB (200 mV/decade) nominal and can be modified using external resistors and the independent buffer amplifiers. The logarithmic intercepts for each channel are defined by the individual reference currents, which are set to 3 μA nominal for maximum input range by connecting 665 kΩ resistors between the 2.5 V VREF pins and the IRF1 and IRF2 inputs. Tying VRDZ to VREF effectively sets the x-intercept four decades below the reference current—typically 300 pA for a 3 μA reference.

The use of individually optimized reference currents may be valuable when using the ADL5310 for gain or absorbance measurements where each channel input has a different current-range requirement. The reference current inputs are also fully functional dynamic inputs, allowing log ratio operation with the reference input current as the denominator. The ADL5310 is specified for operation from -40°C to +85°C.

<sup>1</sup> US Patents: 5,519,308.

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REVISION HISTORY

|                                               |    |
|-----------------------------------------------|----|
| 9/04—Data Sheet Changed from Rev. 0 to Rev. A |    |
| Changes to Ordering Guide .....               | 20 |
| 11/03—Revision 0: Initial Version             |    |

## SPECIFICATIONS

$V_P = 5\text{ V}$ ,  $V_N = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$ ,  $R_{REF} = 665\text{ k}\Omega$ , and  $VRDZ$  connected to  $V_{REF}$ , unless otherwise noted.

Table 1.

| Parameter                            | Conditions                                                                                            | Min          | Typ            | Max          | Unit                           |
|--------------------------------------|-------------------------------------------------------------------------------------------------------|--------------|----------------|--------------|--------------------------------|
| <b>INPUT INTERFACE</b>               |                                                                                                       |              |                |              |                                |
| Specified Current Range, $I_{PD}$    | Pins 1 to 6: INP1 and INP2, IRF1 and IRF2, $V_{SUM}$<br>Flows toward INP1 pin or INP2 pin             | 3 n          |                | 3 m          | A                              |
| Input Current Min/Max Limits         | Flows toward INP1 pin or INP2 pin                                                                     |              |                | 10 m         | A                              |
| Reference Current, $I_{REF}$ , Range | Flows toward IRF1 pin or IRF2 pin                                                                     | 3 n          |                | 3 m          | A                              |
| Summing Node Voltage                 | Internally preset; user alterable                                                                     | 0.46         | 0.5            | 0.54         | V                              |
| Temperature Drift                    | $-40^\circ\text{C} < T_A < +85^\circ\text{C}$                                                         |              | 0.030          |              | mV/ $^\circ\text{C}$           |
| Input Offset Voltage                 | $V_{IN} - V_{SUM}$ , $V_{IREF} - V_{SUM}$                                                             | -20          |                | +20          | mV                             |
| <b>LOGARITHMIC OUTPUTS</b>           |                                                                                                       |              |                |              |                                |
| Logarithmic Slope                    | Pin 15 and Pin 16: LOG1 and LOG2<br><br>$-40^\circ\text{C} < T_A < +85^\circ\text{C}$                 | 190<br>185   | 200            | 210<br>215   | mV/dec<br>mV/dec               |
| Logarithmic Intercept <sup>1</sup>   | $-40^\circ\text{C} < T_A < +85^\circ\text{C}$                                                         | 165<br>40    | 300            | 535<br>1940  | pA<br>pA                       |
| Law Conformance Error                | $10\text{ nA} < I_{PD} < 1\text{ mA}$<br>$3\text{ nA} < I_{PD} < 3\text{ mA}$                         |              | 0.1<br>0.3     | 0.4<br>0.6   | dB<br>dB                       |
| Wideband Noise <sup>2</sup>          | $I_{PD} > 3\text{ }\mu\text{A}$ ; output referred                                                     |              | 0.5            |              | $\mu\text{V}/\sqrt{\text{Hz}}$ |
| Small Signal Bandwidth               | $I_{PD} = 3\text{ }\mu\text{A}$                                                                       |              | 1.5            |              | MHz                            |
| Maximum Output Voltage               |                                                                                                       |              | 1.7            |              | V                              |
| Minimum Output Voltage               | Limited by $V_N = 0\text{ V}$                                                                         |              | 0.10           |              | V                              |
| Output Resistance                    |                                                                                                       | 4.375        | 5              | 5.625        | k $\Omega$                     |
| <b>REFERENCE OUTPUT</b>              |                                                                                                       |              |                |              |                                |
| Voltage wrt Ground                   | Pin 7 and Pin 24 (internally shorted): $V_{REF}$<br><br>$-40^\circ\text{C} < T_A < +85^\circ\text{C}$ | 2.45<br>2.42 | 2.5            | 2.55<br>2.58 | V<br>V                         |
| Maximum Output Current               | Sourcing (grounded load)                                                                              |              | 20             |              | mA                             |
| Incremental Output Resistance        | Load current $< 10\text{ mA}$                                                                         |              | 4              |              | $\Omega$                       |
| <b>OUTPUT BUFFERS</b>                |                                                                                                       |              |                |              |                                |
| Input Offset Voltage                 | Pins 12 to 14 and 17 to 19: OUT2, SCL2, BIN2, BIN1, SCL1, and OUT1                                    | -20          |                | +20          | mV                             |
| Input Bias Current                   | Flowing out of Pins 13, 14, 17, and 18                                                                |              | 0.4            |              | $\mu\text{A}$                  |
| Incremental Input Resistance         |                                                                                                       |              | 35             |              | M $\Omega$                     |
| Incremental Output Resistance        | Load current $< 10\text{ mA}$ ; gain = 1                                                              |              | 0.5            |              | $\Omega$                       |
| Output High Voltage                  | $R_L = 1\text{ k}\Omega$ to ground                                                                    |              | $V_P -$<br>0.1 |              | V                              |
| Output Low Voltage                   | $R_L = 1\text{ k}\Omega$ to ground                                                                    |              | 0.10           |              | V                              |
| Peak Source/Sink Current             |                                                                                                       |              | 30             |              | mA                             |
| Small-Signal Bandwidth               | Gain = 1                                                                                              |              | 15             |              | MHz                            |
| Slew Rate                            | 0.2 V to 4.8 V output swing                                                                           |              | 15             |              | V/ $\mu\text{s}$               |
| <b>POWER SUPPLY</b>                  |                                                                                                       |              |                |              |                                |
| Positive Supply Voltage              | Pins 8 and 9: $V_{POS}$ ; Pins 10, 11, and 20: $V_{NEG}$<br>$(V_P - V_N) \leq 12\text{ V}$            | 3            | 5              | 12           | V                              |
| Quiescent Current                    | Input currents $< 10\text{ }\mu\text{A}$                                                              |              | 9.5            | 11.5         | mA                             |
| Negative Supply Voltage (Optional)   | $(V_P - V_N) \leq 12\text{ V}$                                                                        | -5.5         | 0              |              | V                              |

<sup>1</sup> Other values of logarithmic intercept can be achieved by adjustment of  $R_{REF}$ .

<sup>2</sup> Output noise and incremental bandwidth are functions of input current; measured using output buffer connected for GAIN = 1.

## ABSOLUTE MAXIMUM RATINGS

Table 2.

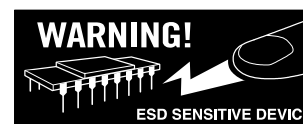
| Parameter                                   | Rating                        |
|---------------------------------------------|-------------------------------|
| Supply Voltage $V_P - V_N$                  | 12 V                          |
| Input Current                               | 20 mA                         |
| Internal Power Dissipation<br>$\theta_{JA}$ | 500 mW<br>35°C/W <sup>1</sup> |
| Maximum Junction Temperature                | 125°C                         |
| Operating Temperature Range                 | –40°C to +85°C                |
| Storage Temperature Range                   | –65°C to +150°C               |
| Lead Temperature Range (Soldering 60 sec)   | 300°C                         |

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

<sup>1</sup> With paddle soldered down.

### ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

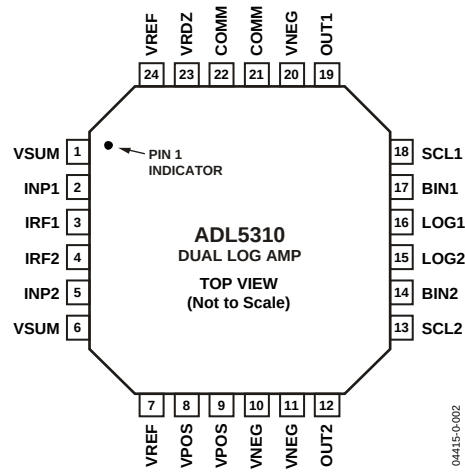


Figure 2. 24-Lead LFCSP Pin Configuration

Table 3. Pin Function Descriptions

| Pin No.    | Mnemonic | Function                                                                                                                                                                                                                  |
|------------|----------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1, 6       | VSUM     | Guard Pin. Used to shield the INP1 and INP2 input current lines, and for optional adjustment of the input summing node potentials. Pin 1 and Pin 6 are internally shorted.                                                |
| 2          | INP1     | Channel 1 Numerator Input. Accepts (sinks) photodiode current $I_{PD1}$ . Usually connected to photodiode anode such that photocurrent flows into INP1.                                                                   |
| 3          | IRF1     | Channel 1 Denominator Input. Accepts (sinks) reference current, $I_{RF1}$ .                                                                                                                                               |
| 4          | IRF2     | Channel 2 Denominator Input. Accepts (sinks) reference current, $I_{RF2}$ .                                                                                                                                               |
| 5          | INP2     | Channel 2 Numerator Input. Accepts (sinks) photodiode current $I_{PD2}$ . Usually connected to photodiode anode such that photocurrent flows into INP2.                                                                   |
| 7, 24      | VREF     | Reference Output Voltage of 2.5 V. Pin 7 and Pin 24 are internally shorted.                                                                                                                                               |
| 8, 9       | VPOS     | Positive Supply, $(V_P - V_N) \leq 12$ V. Both pins must be connected externally.                                                                                                                                         |
| 10, 11, 20 | VNEG     | Optional Negative Supply, $V_N$ . These pins are usually grounded. For more details, see the General Structure and Applications sections. All VNEG pins must be connected externally.                                     |
| 12         | OUT2     | Buffer Output for Channel 2.                                                                                                                                                                                              |
| 13         | SCL2     | Buffer Amplifier Inverting Input for Channel 2.                                                                                                                                                                           |
| 14         | BIN2     | Buffer Amplifier Noninverting Input for Channel 2.                                                                                                                                                                        |
| 15         | LOG2     | Output of the Logarithmic Front End for Channel 2.                                                                                                                                                                        |
| 16         | LOG1     | Output of the Logarithmic Front End for Channel 1.                                                                                                                                                                        |
| 17         | BIN1     | Buffer Amplifier Noninverting Input for Channel 1.                                                                                                                                                                        |
| 18         | SCL1     | Buffer Amplifier Inverting Input for Channel 1.                                                                                                                                                                           |
| 19         | OUT1     | Buffer Output for Channel 1.                                                                                                                                                                                              |
| 21, 22     | COMM     | Analog Ground. Pin 21 and Pin 22 are internally shorted.                                                                                                                                                                  |
| 23         | VRDZ     | Intercept Shift Reference Input. The top of a resistive divider network that offsets VLOG to position the intercept. Normally connected to VREF; may also be connected to ground when bipolar outputs are to be provided. |

## TYPICAL PERFORMANCE CHARACTERISTICS

$V_P = 5\text{ V}$ ,  $V_N = 0\text{ V}$ ,  $R_{REF} = 665\text{ k}\Omega$ ,  $T_A = 25^\circ\text{C}$ , unless otherwise noted.

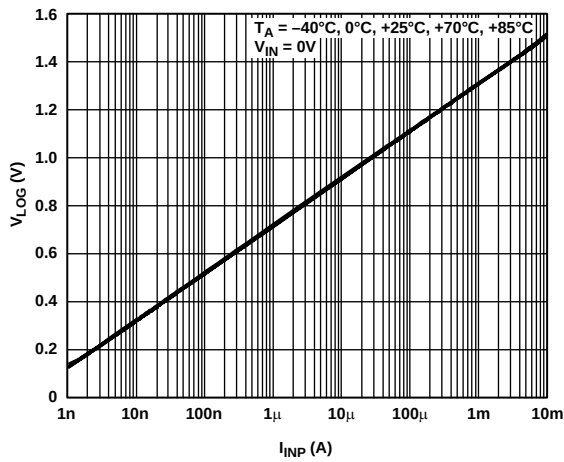


Figure 3.  $V_{LOG}$  vs.  $I_{INP}$  for Multiple Temperatures

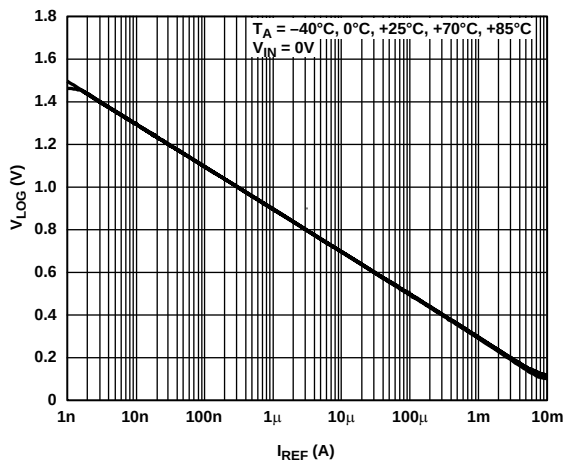


Figure 4.  $V_{LOG}$  vs.  $I_{REF}$  for Multiple Temperatures ( $I_{INP} = 3\text{ }\mu\text{A}$ )

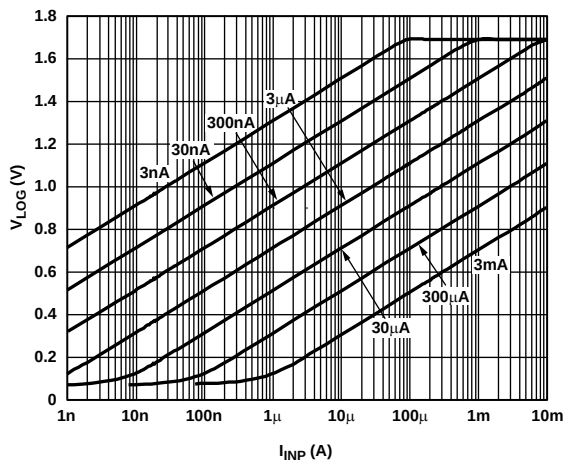


Figure 5.  $V_{LOG}$  vs.  $I_{INP}$  for Multiple Values of  $I_{REF}$ , Decade Steps from 3 nA to 3 mA

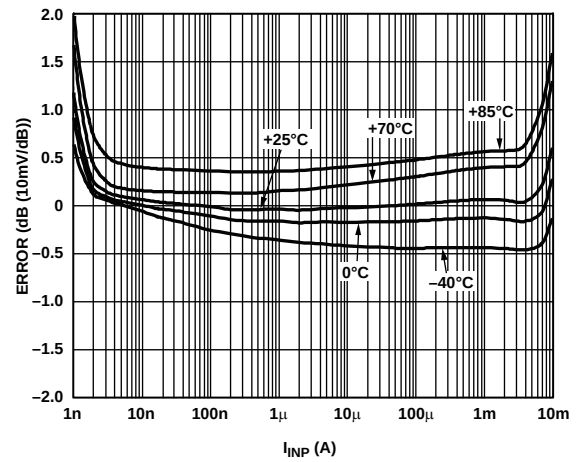


Figure 6. Law Conformance Error vs.  $I_{INP}$  for Multiple Temperatures, Normalized to  $25^\circ\text{C}$

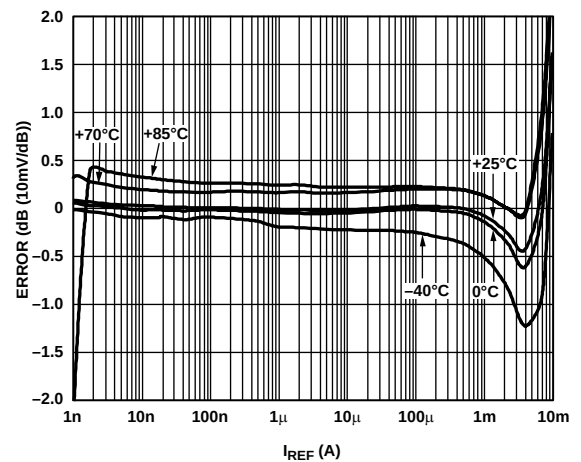


Figure 7. Law Conformance Error vs.  $I_{REF}$  for Multiple Temperatures, Normalized to  $25^\circ\text{C}$  ( $I_{INP} = 3\text{ }\mu\text{A}$ )

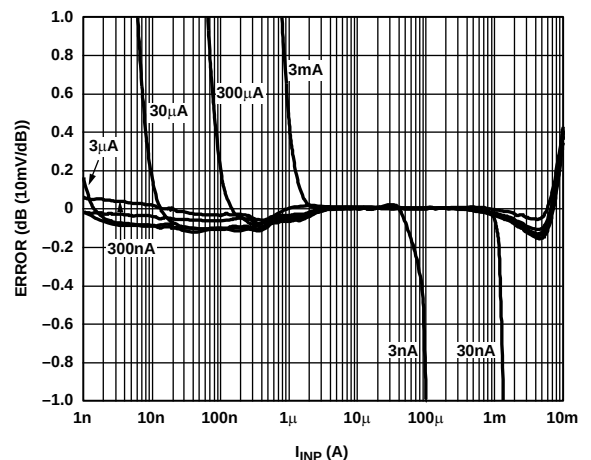


Figure 8. Law Conformance Error vs.  $I_{INP}$  for Multiple Values of  $I_{REF}$ , Decade Steps from 3 nA to 3 mA

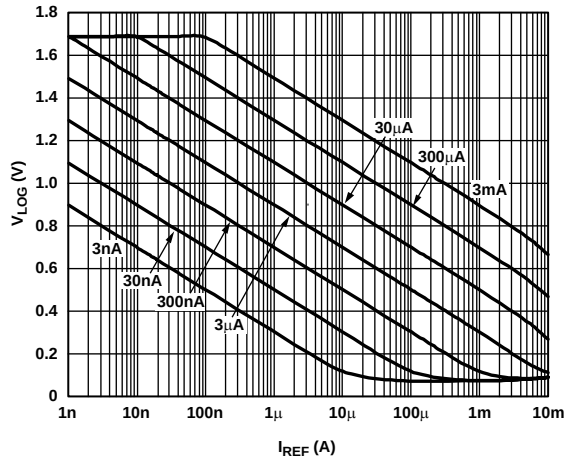


Figure 9.  $V_{LOG}$  vs.  $I_{REF}$  for Multiple Values of  $I_{INP}$ , Decade Steps from 3 nA to 3 mA

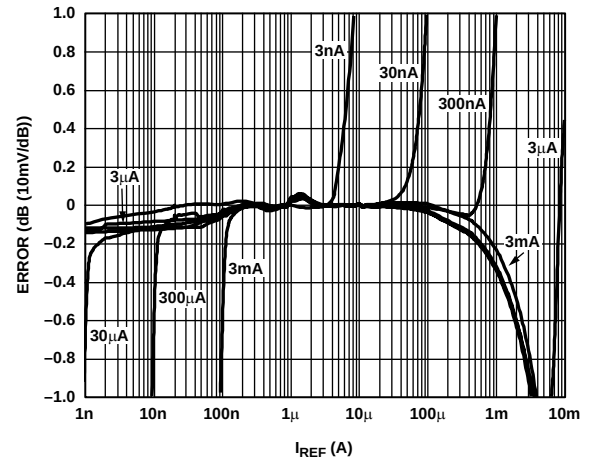


Figure 12. Law Conformance Error vs.  $I_{REF}$  for Multiple Values of  $I_{INP}$ , Decade Steps from 3 nA to 3 mA

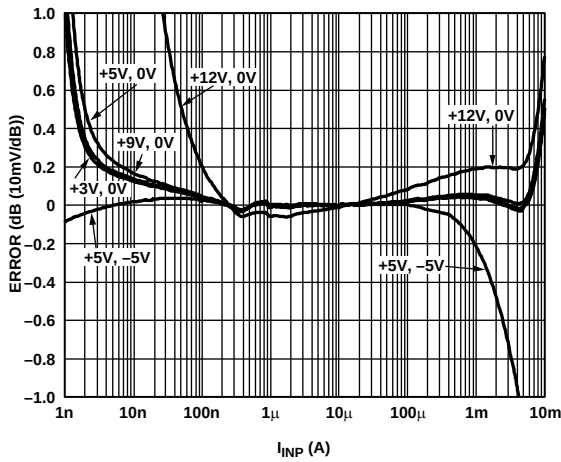


Figure 10. Law Conformance Error vs.  $I_{INP}$  for Various Supply Conditions

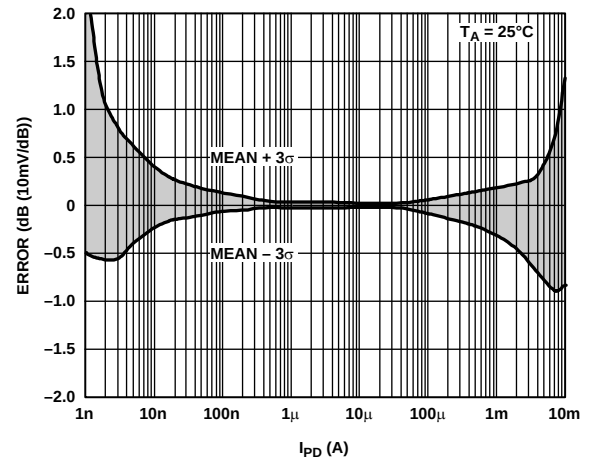


Figure 13. Law Conformance Error Distribution ( $3\sigma$  to Either Side of Mean)

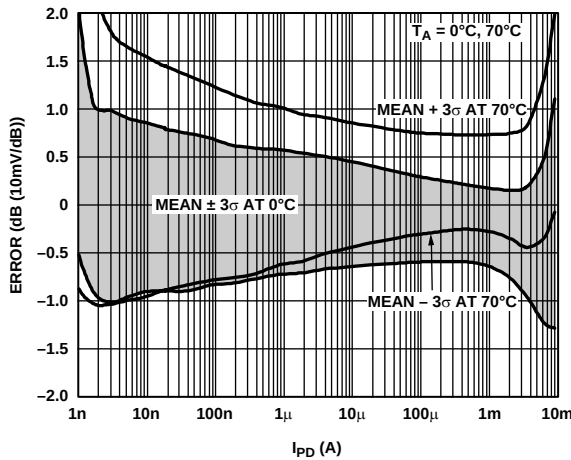


Figure 11. Law Conformance Error Distribution ( $3\sigma$  to Either Side of Mean)

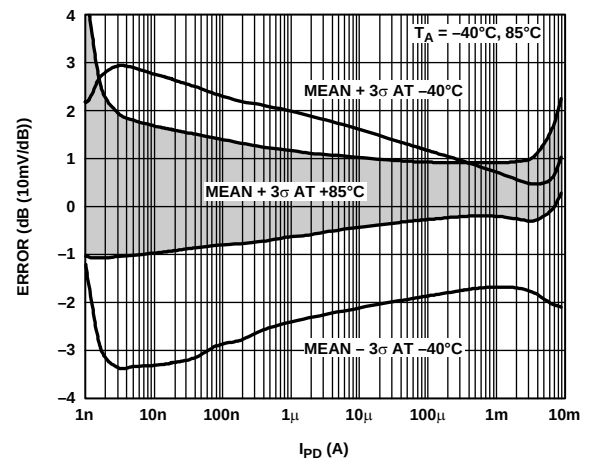


Figure 14. Law Conformance Error Distribution ( $3\sigma$  to Either Side of Mean)

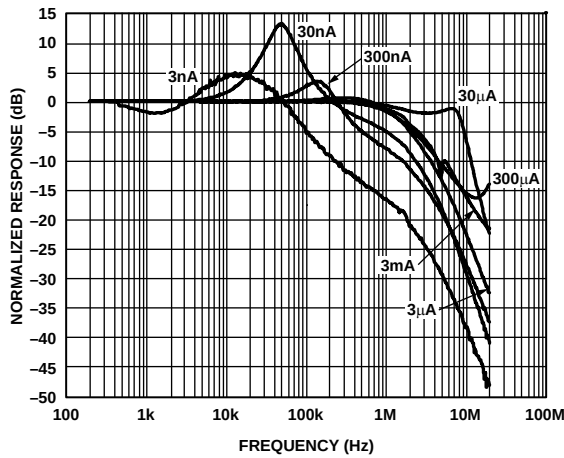


Figure 15. Small Signal AC Response,  $I_{INP}$  to  $V_{OUT}$  ( $A_V = 1$ ) (5% Sine Modulation, Decade Steps from 3 nA to 3 mA)

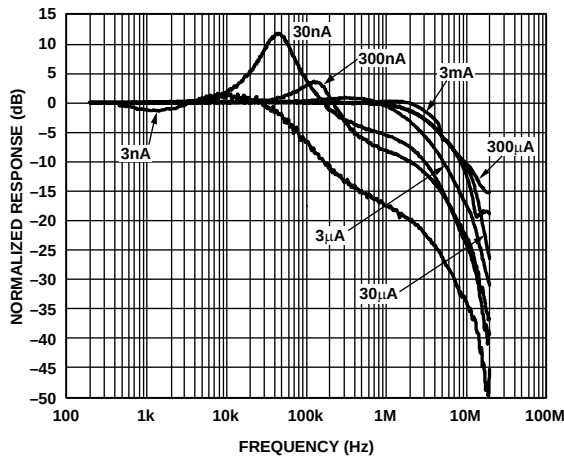


Figure 16. Small Signal AC Response,  $I_{REF}$  to  $V_{OUT}$  ( $A_V = 1$ ) (5% Sine Modulation, Decade Steps from 3 nA to 3 mA)

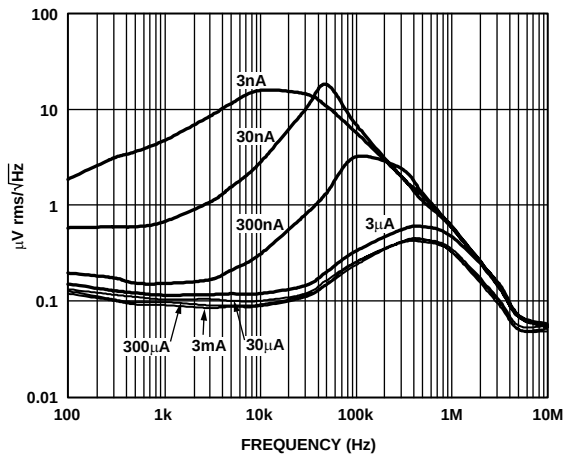


Figure 17. Spot Noise Spectral Density at  $V_{OUT}$  vs. Frequency ( $A_V = 1$ ) for  $I_{INP}$  in Decade Steps from 3 nA to 3 mA

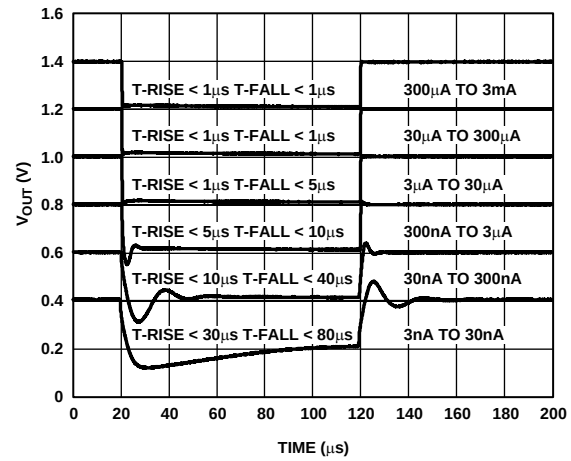


Figure 18. Pulse Response— $I_{INP}$  to  $V_{OUT}$  ( $A_V = 1$ ) in Consecutive 1-Decade Steps

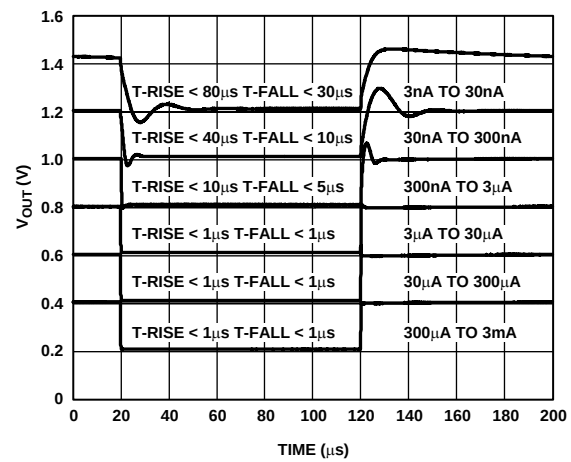


Figure 19. Pulse Response— $I_{REF}$  to  $V_{OUT}$  ( $A_V = 1$ ) in Consecutive 1-Decade Steps

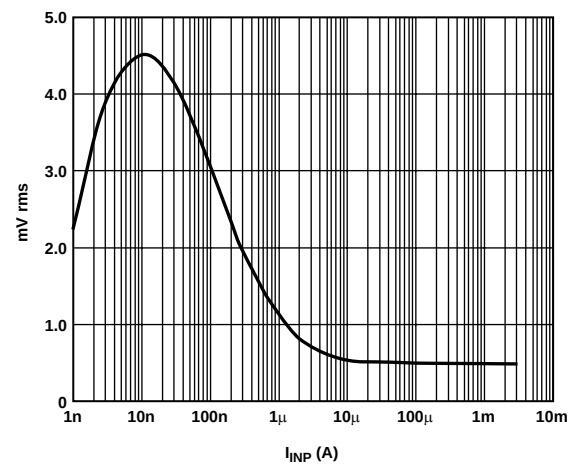
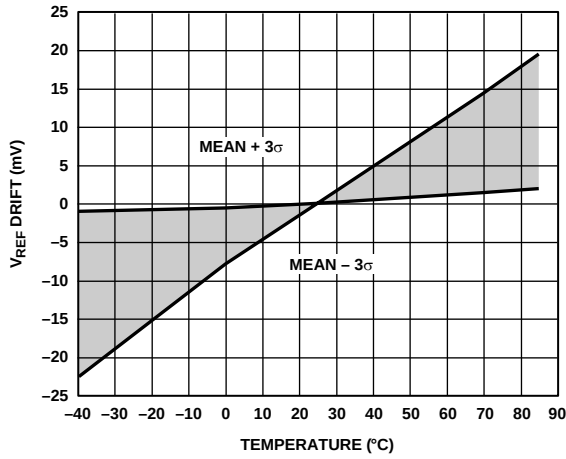


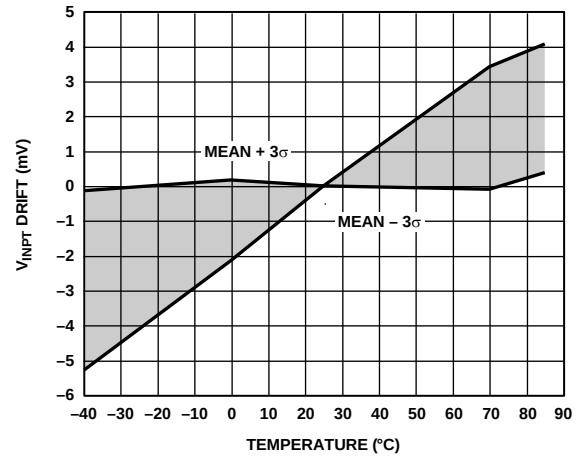
Figure 20. Total Wideband Noise Voltage at  $V_{OUT}$  vs.  $I_{INP}$  ( $A_V = 1$ )





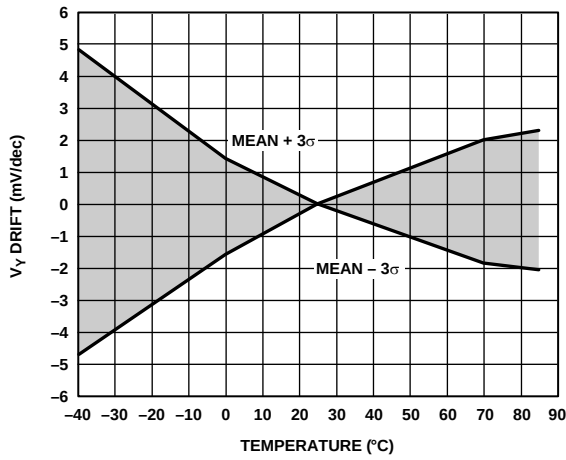
04415-0-021

Figure 21.  $V_{REF}$  Drift vs. Temperature ( $3\sigma$  to Either Side of Mean) Normalized to 25°C



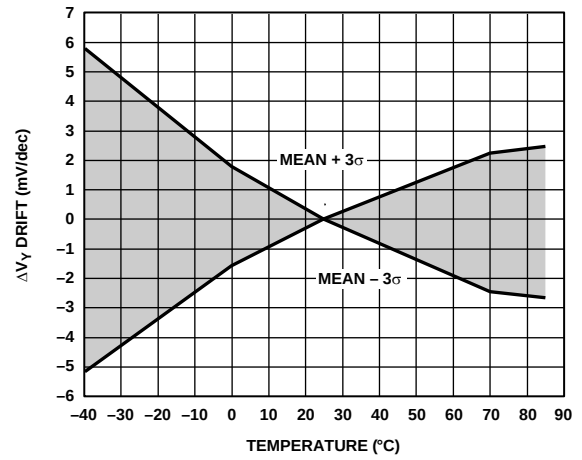
04415-0-024

Figure 24.  $V_{INPT}$  Drift vs. Temperature ( $3\sigma$  to Either Side of Mean) Normalized to 25°C



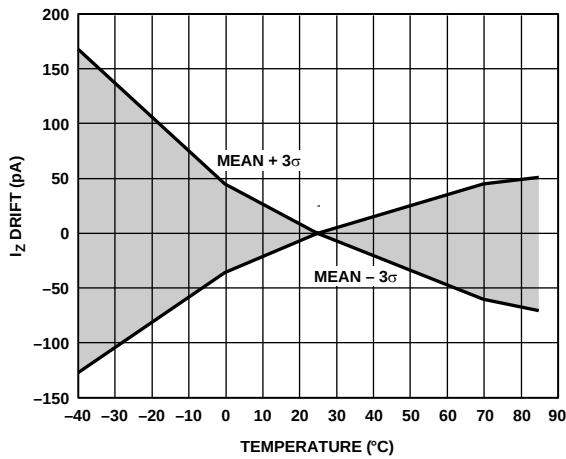
04415-0-022

Figure 22. Slope Drift vs. Temperature ( $3\sigma$  to Either Side of Mean) Normalized to 25°C



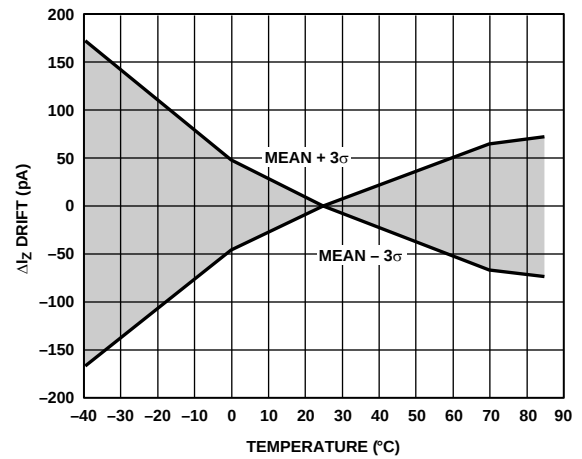
04415-0-025

Figure 25. Slope Mismatch Drift vs. Temperature ( $V_{Y1} - V_{Y2}$ ,  $3\sigma$  to Either Side of Mean) Normalized to 25°C



04415-0-023

Figure 23. Intercept Drift vs. Temperature ( $3\sigma$  to Either Side of Mean) Normalized to 25°C



04415-0-026

Figure 26. Intercept Mismatch Drift vs. Temperature ( $I_{Z1} - I_{Z2}$ ,  $3\sigma$  to Either Side of Mean) Normalized to 25°C

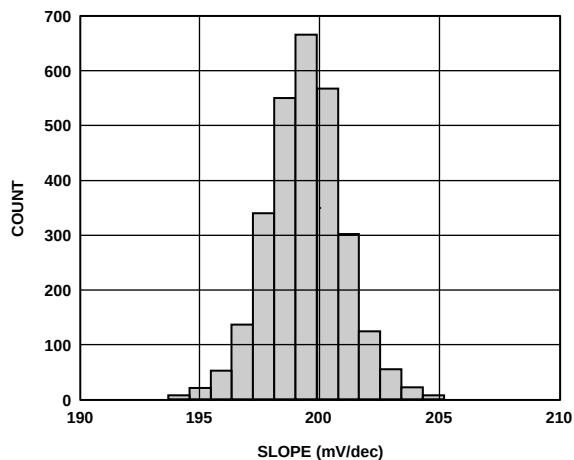


Figure 27. Distribution of Logarithmic Slope

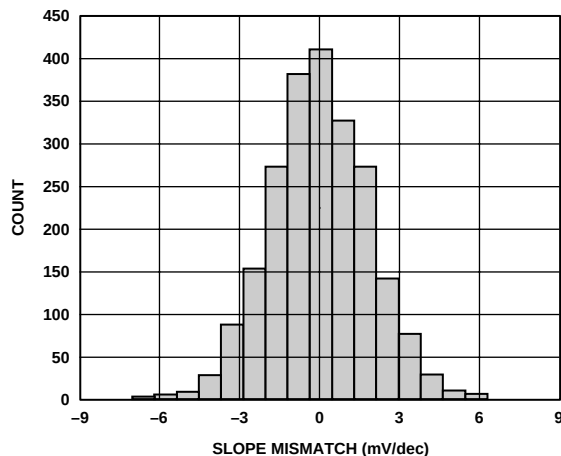


Figure 30. Distribution of Channel-to-Channel Slope Mismatch ( $V_{I1} - V_{I2}$ )

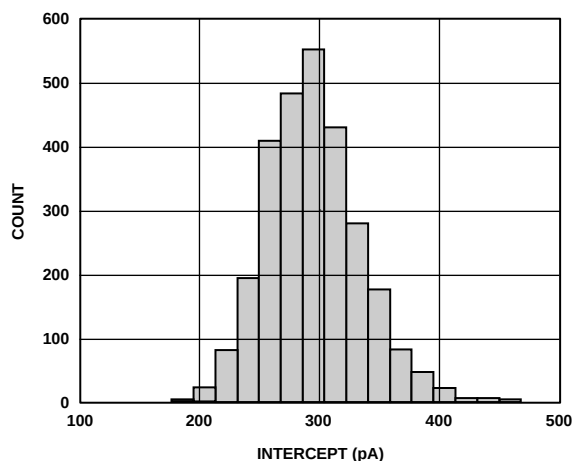


Figure 28. Distribution of Logarithmic Intercept

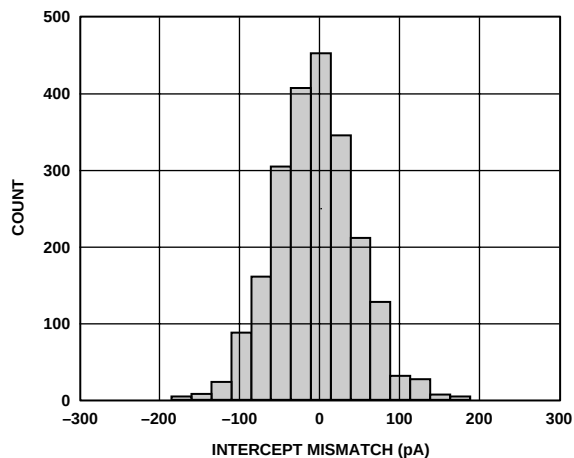


Figure 31. Distribution of Channel-to-Channel Intercept Mismatch ( $I_{I1} - I_{I2}$ )

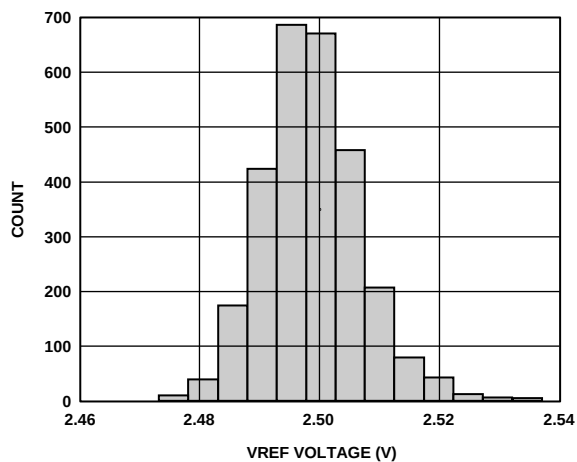


Figure 29. Distribution of  $V_{REF}$  ( $R_L = 100\text{ k}\Omega$ )

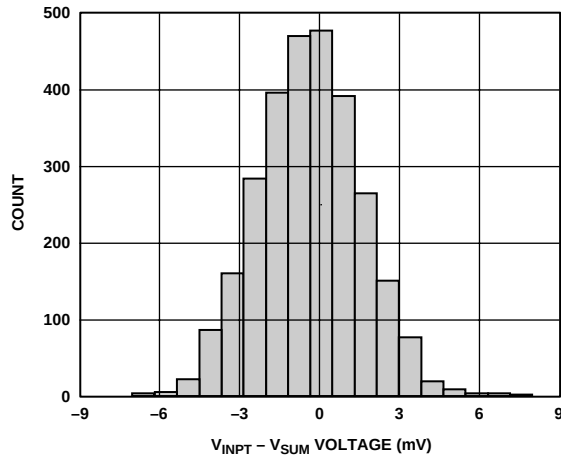


Figure 32. Distribution of Offset Voltage ( $V_{INPT} - V_{SUM}$ )

## GENERAL STRUCTURE

The ADL5310 addresses a wide variety of interfacing conditions to meet the needs of fiber optic supervisory systems and is useful in many nonoptical applications. These notes explain the structure of this unique style of translinear log amp. Figure 33 shows the key elements of one of the two identical on-board log amps.

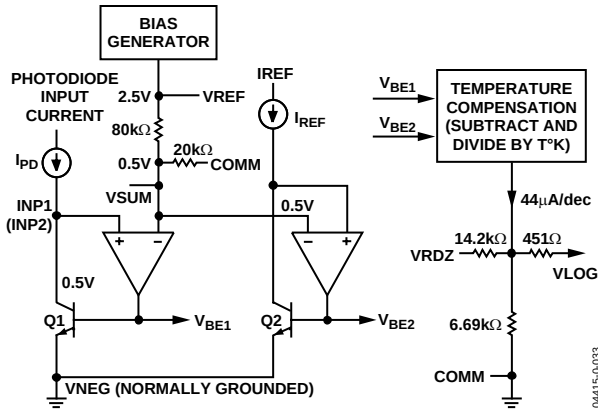


Figure 33. Simplified Schematic of Single Log Amp

The photodiode current  $I_{PD}$  is received at either Pin INP1 or Pin INP2. The voltages at these nodes are approximately equal to the voltage on the adjacent guard pins, VSUM, as well as reference inputs IRF1 and IRF2, due to the low offset voltage of the JFET operational amplifiers. Transistor Q1 converts  $I_{PD}$  to a corresponding logarithmic voltage, as shown in Equation 1. A finite positive value of  $V_{SUM}$  is needed to bias the collector of Q1 for the usual case of a single-supply voltage. This is internally set to 0.5 V, one-fifth of the 2.5 V reference voltage that appears on Pin VREF. Both VREF pins are internally shorted, as are both VSUM pins. The resistance at the VSUM pin is nominally 16 kΩ; this voltage is not intended as a general bias source.

The ADL5310 also supports the use of an optional negative supply voltage,  $V_N$ , at Pin VNEG. When  $V_N$  is 0.5 V or more negative, VSUM may be connected to ground; thus, INP1, INP2, IRF1, and IRF2 assume this potential. This allows operation as a voltage-input logarithmic converter by the inclusion of a series resistor at either or both inputs. Note that the resistor setting  $I_{REF}$  for each channel needs to be adjusted to maintain the intercept value. Also note that the collector-emitter voltages of Q1 and Q2 are the full  $V_N$  and effects due to self-heating cause errors at large input currents.

The input-dependent  $V_{BE1}$  of Q1 is compared with the reference  $V_{BE2}$  of a second transistor, Q2, operating at  $I_{REF}$ .  $I_{REF}$  is generated externally to a recommended value of 3 μA. However, other values over a several-decade range can be used with a slight degradation in law conformance.

## THEORY

The base-emitter voltage of a bipolar junction transistor (BJT) can be expressed by Equation 1, which immediately shows its basic logarithmic nature:

$$V_{BE} = kT/q \ln(I_C/I_S) \quad (1)$$

where:

$I_C$  is the collector current.

$I_S$  is a scaling current, typically only  $10^{-17}$  A.

$kT/q$  is the thermal voltage, proportional to absolute temperature (PTAT), and is 25.85 mV at 300 K.

$I_S$  is never precisely defined and exhibits an even stronger temperature dependence, varying by a factor of roughly a billion between  $-35^\circ\text{C}$  and  $+85^\circ\text{C}$ . Thus, to make use of the BJT as an accurate logarithmic element, both of these temperature dependencies must be eliminated.

The difference between the base-emitter voltages of a matched pair of BJTs, one operating at the photodiode current  $I_{PD}$  and the other operating at a reference current  $I_{REF}$ , can be written as

$$\begin{aligned} V_{BE1} - V_{BE2} &= kT/q \ln(I_{PD}/I_S) - kT/q \ln(I_{REF}/I_S) \\ &= \ln(10) kT/q \log_{10}(I_{PD}/I_{REF}) \\ &= 59.5 \text{ mV} \log_{10}(I_{PD}/I_{REF}) \quad (T = 300 \text{ K}) \end{aligned} \quad (2)$$

The uncertain, temperature-dependent saturation current,  $I_S$ , that appears in Equation 1 has therefore been eliminated. To eliminate the temperature variation of  $kT/q$ , this difference voltage is processed by what is essentially an analog divider. Effectively, it puts a variable under Equation 2. The output of this process, which also involves a conversion from voltage mode to current mode, is an intermediate, temperature-corrected current:

$$I_{LOG} = I_Y \log_{10}(I_{PD}/I_{REF}) \quad (3)$$

where  $I_Y$  is an accurate, temperature-stable scaling current that determines the slope of the function (change in current per decade). For the ADL5310,  $I_Y$  is 44 μA, resulting in a temperature-independent slope of 44 μA/decade for all values of  $I_{PD}$  and  $I_{REF}$ . This current is subsequently converted back to a voltage-mode output,  $V_{LOG}$ , scaled 200 mV/decade.

It is apparent that this output should be 0 for  $I_{PD} = I_{REF}$  and would need to swing negative for smaller values of input current. To avoid this,  $I_{REF}$  would need to be as small as the smallest value of  $I_{PD}$ . Accordingly, an offset voltage is added to  $V_{LOG}$  to shift it upward by 0.8 V when VRDZ is directly connected to VREF. This moves the intercept to the left by four decades (at 200 mV/decade), from 3 μA to 300 pA:

$$I_{LOG} = I_Y \log_{10}(I_{PD}/I_{INTC}) \quad (4)$$

where  $I_{INTC}$  is the operational value of the intercept current. Because values of  $I_{PD} < I_{INTC}$  result in a negative  $V_{LOG}$ , a negative supply of sufficient value is required to accommodate this situation.

The voltage  $V_{LOG}$  is generated by applying  $I_{LOG}$  to an internal resistance of 4.55 k $\Omega$ , formed by the parallel combination of a 6.69 k $\Omega$  resistor to ground and a 14.2 k $\Omega$  resistor to Pin VRDZ (typically tied to the 2.5 V reference, VREF). At the LOG1 (LOG2) pin, the output current  $I_{LOG}$  generates a voltage of

$$\begin{aligned} V_{LOG} &= I_{LOG} \times 4.55 \text{ k}\Omega \\ &= 44 \text{ }\mu\text{A} \times 4.55 \text{ k}\Omega \times \log_{10}(I_{PD}/I_{INTC}) \\ &= V_Y \log_{10}(I_{PD}/I_{INTC}) \end{aligned} \quad (5)$$

where  $V_Y = 200 \text{ mV/decade}$  or  $10 \text{ mV/dB}$ . Note that any resistive loading on LOG1 (LOG2) lowers this slope and results in an overall scaling uncertainty. This is due to the variability of the on-chip resistors compared to the off-chip load. As a consequence, this practice is not recommended.

$V_{LOG}$  may also swing below ground when dual supplies ( $V_P$  and  $V_N$ ) are used. When  $V_N = -0.5 \text{ V}$  or larger, the input Pins INP1 (INP2) and IRF1 (INP2) may be positioned at ground level simply by grounding VSUM. Care must be taken to limit the power consumed by the input BJT devices when using a larger negative supply, because self-heating degrades the accuracy at higher currents.

## MANAGING INTERCEPT AND SLOPE

When using a single supply, VRDZ should be directly connected to VREF to allow operation over the entire 6-decade input current range. As noted in the Theory section, this introduces an accurate offset voltage of 0.8 V at the LOG1 and LOG2 pins, equivalent to four decades, resulting in a logarithmic transfer function that can be written as

$$\begin{aligned} V_{LOG} &= V_Y \log_{10}(10^4 \times I_{PD}/I_{REF}) \\ &= V_Y \log_{10}(I_{PD}/I_{INTC}) \end{aligned} \quad (6)$$

where  $I_{INTC} = I_{REF}/10^4$ .

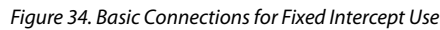
Thus, the effective intercept current  $I_{INTC}$  is only one ten-thousandth of  $I_{REF}$ , corresponding to 300 pA when using the recommended value of  $I_{REF} = 3 \text{ }\mu\text{A}$ .

The slope can be reduced by attaching a resistor between the log amp output pin, LOG1 or LOG2, and ground. This is strongly discouraged given that the on-chip resistors do not ratio correctly to the added resistance. Also, it is rare that one would wish to lower the basic slope of 10 mV/dB; if this is needed, it should be effected at the low impedance output of the buffer amps, which are provided to avoid such miscalibration and to allow higher slopes to be used.

Each of the ADL5310's buffers is essentially an uncommitted operational amplifier with rail-to-rail output swing, good load-driving capabilities, and a typical unity-gain bandwidth of 15 MHz. In addition to allowing the introduction of gain, using standard feedback networks and thereby increasing the slope voltage  $V_Y$ , the buffer can be used to implement multipole, low-pass filters, threshold detectors, and a variety of other functions. Further details on these applications can be found in the AD8304 data sheet.

## RESPONSE TIME AND NOISE CONSIDERATIONS

The response time and output noise of the ADL5310 are fundamentally a function of the signal current,  $I_{PD}$ . For small currents, the bandwidth is proportional to  $I_{PD}$ , as shown in Figure 15. The output low frequency voltage-noise spectral-density is a function of  $I_{PD}$  (see Figure 17) and also increases for small values of  $I_{REF}$ . Details of the noise and bandwidth performance of translinear log amps can be found in the AD8304 data sheet.



Any temperature variation in  $R_{RF1}$  ( $R_{RF2}$ ) must be taken into account when estimating the stability of the intercept. Also, the overall noise increases when using very low values of  $I_{RF1}$  ( $I_{RF2}$ ). In fixed-intercept applications there is little benefit in using a large reference current, because doing so only compresses the low-current-end of the dynamic range when operated from a single supply. The capacitor between VSUM and ground is

In addition, each input and reference pin (INP1, INP2, IRF1, and IRF2) has a compensation network made up of a series resistor and capacitor. The junction capacitance of the photodiode along with the network capacitance of the board artwork around the input system creates a pole that varies widely with input current. The RC network stabilizes the system by simultaneously reducing this pole frequency and inserting a zero to compensate an additional pole inherent in the input system. In general, the 1 nF, 1 k $\Omega$  network handles almost any photodiode interface. In situations where larger active area photodiodes are used, or when long input traces are used, the capacitor value may need to be increased to ensure stability. Although the signal and reference input systems are similar, additional care is required to ensure stable operation of the reference inputs at temperature extremes across the full current range of  $I_{RF1}$  ( $I_{RF2}$ ). It is recommended that filter components of 4.7 nF and 2 k $\Omega$  should be used from Pin IRF1 (IRF2) to ground. Temperature-stable components should always be used in critical locations such as the compensation networks; Y5V-type chip capacitors are to be avoided due to their poor temperature stability.

The optional capacitor from LOG1 (LOG2) to ground forms a single-pole, low-pass filter in combination with the 5 kΩ resistance at this pin. For example, when using a  $C_{FLT}$  of 10 nF, the 3 dB corner frequency is 3.2 kHz. Such filtering is useful in minimizing the output noise, particularly when  $I_{PD}$  is small. Multipole filters are more effective in reducing the total noise; examples are provided in the AD8304 data sheet.

Because the basic scaling at LOG1 (LOG2) is 0.2 V/decade, and thus a 4 V swing at the buffer output would correspond to 20 decades, it is often useful to raise the slope to make better use of the rail-to-rail voltage range. For illustrative purposes, both channels in Figure 34 provide a 0.5 V/decade overall slope (25 mV/dB). Thus, using  $I_{REF} = 3 \mu A$ ,  $V_{LOG}$  runs from 0.2 V at  $I_{PD} = 3 \text{ nA}$  to 1.4 V at  $I_{PD} = 3 \text{ mA}$ ; the buffer output runs from 0.5 V to 3.5 V, corresponding to a dynamic range of 120 dB (electrical, that is, 60 dB optical power).

Further information on adjusting the slope and intercept, using a negative supply, and additional operations can be found in the AD8305 data sheet.

## CALIBRATION

Each channel of the ADL5310 has a nominal slope and intercept at LOG1 (LOG2) of 200 mV/decade and 300 pA, respectively, when configured as shown in Figure 34. These values are untrimmed and the slope alone may vary by as much as 7.5% over temperature. For this reason, it is recommended that a simple calibration be done to achieve increased accuracy. While the ADL5310 offers improved slope and intercept matching compared to a randomly selected pair of AD8305 log amps, the specified accuracy can only be achieved by calibrating each channel individually.

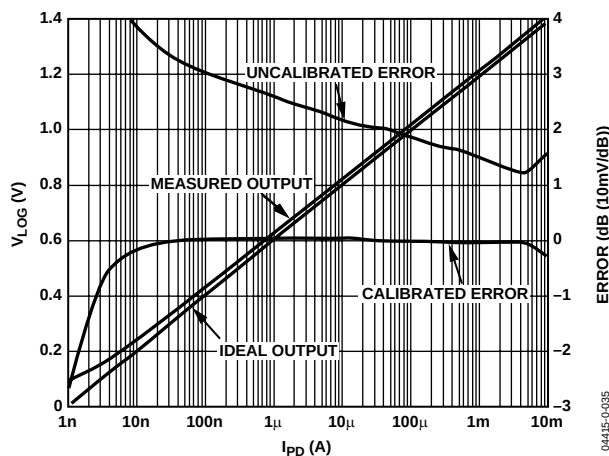


Figure 35. Using 2-Point Calibration to Increase Measurement Accuracy

Figure 35 shows the improvement in accuracy when using a 2-point calibration method. To perform this calibration, apply two known currents,  $I_1$  and  $I_2$ , in the linear operating range between 10 nA and 1 mA. Measure the resulting output,  $V_1$  and  $V_2$ , respectively, and calculate the slope  $m$  and the intercept  $b$ :

$$m = (V_1 - V_2) / [\log_{10}(I_1) - \log_{10}(I_2)] \quad (7)$$

$$b = V_1 - m \times \log_{10}(I_1) \quad (8)$$

The same calibration could be performed with two known optical powers,  $P_1$  and  $P_2$ . This allows for calibration of the entire measurement system while providing a simplified relationship between the incident optical power and  $V_{LOG}$  voltage:

$$m = (V_1 - V_2) / (P_1 - P_2) \quad (9)$$

$$b = V_1 - m \times P_1 \quad (10)$$

The uncalibrated error line in Figure 35 was generated assuming that the slope of the measured output was 200 mV/decade when in fact it was actually 194 mV/decade. Correcting for this discrepancy decreased measurement error up to 3 dB.

## MINIMIZING CROSSTALK

Combining two high-dynamic-range logarithmic converters in one IC carries potential pitfalls concerning channel-to-channel isolation. Special care must be taken in several areas to ensure acceptable crosstalk performance, particularly when one or both channels may operate at very low input currents. Fastidious supply bypassing—also necessary for overall stability—and careful board layout are important first steps for minimizing crosstalk.

While the shared bias circuitry improves channel-to-channel matching and reduces power consumption, it is also a source of crosstalk that must be mitigated. The VSUM pins, which are internally shorted, should be bypassed with at least 1 nF to ground, and 20 nF is recommended for operation at the lowest currents (<30 nA). VSUM is of particular importance because it acts as a reference voltage input for each input system, but without the bandwidth limitation at low currents that the primary inputs incur. Disturbances at the VSUM pin that are well within the bandwidth of the input are tracked by the loop and do not generate disturbances at the output (aside from the generally minor perturbation in reference currents caused by voltage variations at IRF1 and IRF2).

For this reason, the pole frequency at VSUM, which has a 16 kΩ typical source resistance, should be set below the minimum input system bandwidth for the lowest input current to be encountered. Because the low frequency noise at VSUM is also tracked by the loop within its available bandwidth, this is also a criterion for reducing the noise contribution at the output from the thermal noise of the 16 kΩ source resistance at VSUM.

A 10 nF capacitor on each VSUM pin (20 nF parallel equivalent) combined with the 16 kΩ source resistance yields a 500 Hz pole, which is sufficiently below the bandwidth for the minimum input current of 3 nA.

Residual crosstalk disturbance is particularly problematic at the lowest currents for two reasons. First, the loop is unable to reject summing node disturbances beyond the limited bandwidth. Second, the settling response at the lowest currents to any residual disturbance is significantly slower than that for input currents even one or two decades higher (see Figure 18).

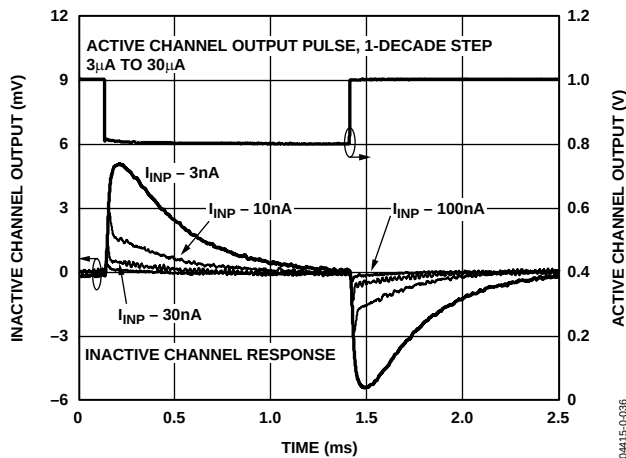


Figure 36. Crosstalk Pulse Response for Various Input Current Values

Figure 36 shows the measured response of an inactive channel (dc input) to a 1-decade current step on the input of the active channel for several inactive channel dc current values. Additional system considerations may be necessary to ensure adequate settling time following a known transient when one or both channels are operating at very low input currents.

## RELATIVE AND ABSOLUTE POWER MEASUREMENTS

When properly calibrated, the ADL5310 provides two independent channels capable of accurate absolute optical power measurements. Often, it is desirable to measure the relative gain or absorbance across an optical network element, such as an optical amplifier or variable attenuator. If each channel has identical logarithmic slopes and intercepts, this can easily be done by differencing the output signals of each channel. In reality, channel mismatch can result in significant errors over a wide range of input levels if left uncompensated. Postprocessing of the signal can be used to account for individual channel characteristics. This requires a simple calculation of the expected input level for a measured log voltage, followed by differencing of the two signal levels in the digital domain for a

relative gain or absorbance measurement. A more straightforward analog implementation includes the use of a current mirror, as shown in Figure 37. The current mirror is used to feed an opposite polarity replica of the cathode photocurrent of PD2 into Channel 2 of the ADL5310. This allows one channel to be used as an absolute power meter for the optical signal incident on PD2, while the opposite channel is used to directly compute the log ratio of the two input signals.

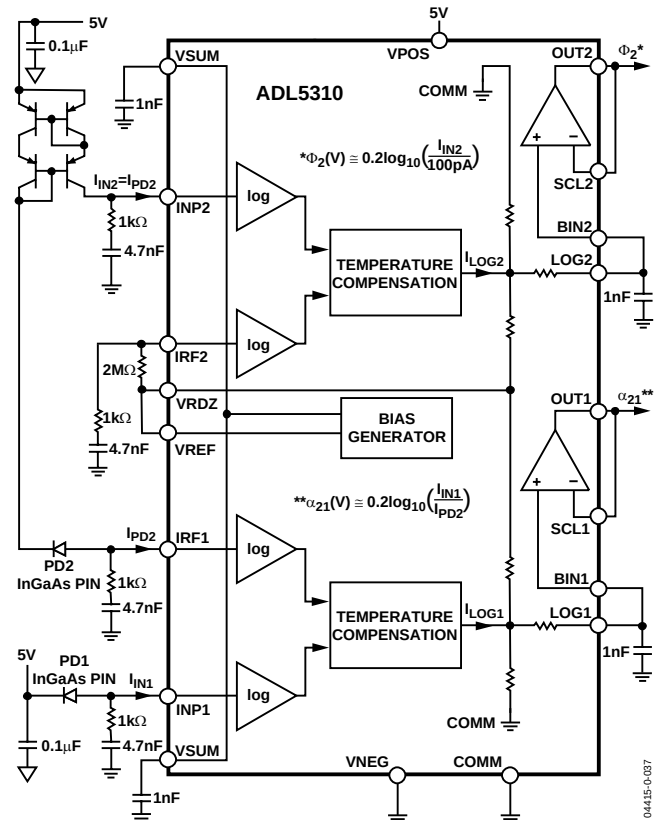


Figure 37. Absolute and Relative Power Measurement Application Using Modified Wilson Current Mirror

The presented current mirror is a modified Wilson mirror. Other current mirror implementations would also work, though the modified Wilson mirror provides fairly constant performance over temperature. It is essential to use matched pair transistors when designing the current mirror to minimize the effects of temperature gradients and beta mismatch.

The solution in Figure 37 is no longer subject to potential channel mismatch issues. Individual channel slope and intercept characteristics can be calibrated independently. The accuracy was verified using a pair of calibrated current sources. The performance of the circuit depicted in Figure 37 is shown in Figure 38 and Figure 39. Multiple transfer functions and error plots are provided for various power levels. The accuracy is better than 0.1 dB over a 5-decade range. The dynamic range is slightly reduced for strong  $I_{IN}$  input currents. This is due to the limited available swing of the VLOG pin and can be recovered through careful selection of input and output optical tap coupling ratios.

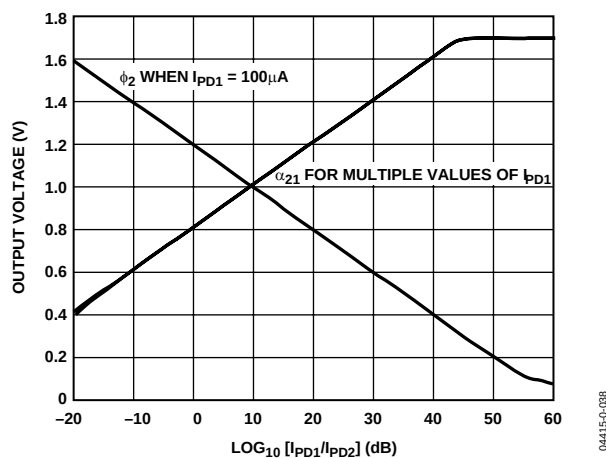


Figure 38. Absorbance and Absolute Power Transfer Functions for Wilson Mirror ADL5310 Combination

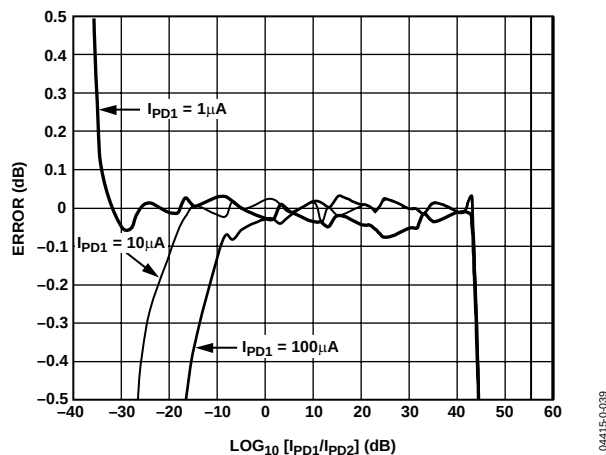


Figure 39. Log Conformance for Wilson Mirror ADL5310 Combination, Normalized to 10 mA Channel 1 Input Current,  $I_{IN1}$

## CHARACTERIZATION METHODS

During the characterization of the ADL5310, the device was treated as a precision current-input logarithmic converter, because it is impractical to generate accurate photocurrents by illuminating a photodiode. The test currents were generated by using either a well-calibrated current source, such as the Keithley 236, or a high value resistor from a voltage source to the input pin. Great care is needed when using very small input currents. For example, the triax output connection from the current generator was used with the guard tied to VSUM. The input trace on the PC board was guarded by connecting adjacent traces to VSUM.

These measures are needed to minimize the risk of leakage current paths. With 0.5 V as the nominal bias on the INP1 (INP2) pin, a leakage-path resistance of 1 G $\Omega$  to ground would subtract 0.5 nA from the input, which amounts to a -1.6 dB error for a 3 nA source current. Additionally, the very high sensitivity at the input pins and the long cables commonly needed during characterization allow 60 Hz and RF emissions to introduce substantial measurement errors. Careful guarding techniques are essential to reducing the pickup of these spurious signals.

Additional information, including test setups, can be found in the AD8305 and ADL5306 data sheets.



## EVALUATION BOARD

An evaluation board is available for the ADL5310 (Figure 40 shows the schematic). It can be configured for a wide variety of experiments. The gain of each buffer amp is factory-set to unity, providing a slope of 200 mV/dec, and the intercept is set to 300 pA. Table 4 describes the various configuration options.

**Table 4. Evaluation Board Configuration Options**

| Component                                                                  | Function                                                                                                                                                                                                                                                                                                                                                                                           | Default Condition                                                                                                                                                                                                                                                                                                                |
|----------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| P1                                                                         | Supply Interface. Provides access to the Supply Pins VNEG, COMM, and VPOS.                                                                                                                                                                                                                                                                                                                         | P1 = installed                                                                                                                                                                                                                                                                                                                   |
| P2, R1, R3, R8, R9, R17, R22, R25, R30                                     | Monitor Interface. By adding 0 $\Omega$ resistors to R1, R3, R8, R9, R17, R22, and R25, the VRDZ, VREF, VSUM, BIN1, BIN2, OUT1, and OUT2 pin voltages can be monitored using a high impedance probe. VBIAS allows for the external bias voltages to be applied to J1 and J2. If R30 = 0 $\Omega$ , VBIAS = VREF.                                                                                   | P2 = not installed<br>R1 = R3 = R8 = open (size 0402)<br>R9 = R17 = open (size 0402)<br>R22 = R25 = R30 = open (size 0402)                                                                                                                                                                                                       |
| R5, R6, R7, R16, R18, R19, R20, R21, R31, R32, C4, C14, C15, C16, C19, C20 | Buffer Amplifier/Output Interface. The logarithmic slopes of the ADL5310 can be altered using each buffer's gain-setting resistors, R5 and R6, and R18 and R19. R7, R16, R31, R32, C19, and C20 allow for variation in the buffer loading. R20, R21, C4, C14, C15, and C16 are provided for a variety of filtering applications.                                                                   | R5 = R19 = 0 $\Omega$ (size 0402)<br>R7 = R16 = 0 $\Omega$ (size 0402)<br>R20 = R21 = 0 $\Omega$ (size 0402)<br>R6 = R18 = open (size 0402)<br>R31 = R32 = open (size 0402)<br>C4 = C14 = open (size 0402)<br>C19 = C20 = open (size 0402)<br>C15 = C16 = open (size 0402)<br>LOG1 = OUT1 = installed<br>LOG2 = OUT2 = installed |
| R2, R28, R29                                                               | Intercept Adjustment. The voltage dropped across Resistors R28 and R29 determines the intercept reference current for each log amp, nominally set to 3 $\mu$ A using a 665 k $\Omega$ 1% resistor. R2 can be used to adjust the output offset voltage at the LOG1 and LOG2 outputs.                                                                                                                | R28 = R29 = 665 k $\Omega$ (size 0402)<br>R2 = 0 $\Omega$ (size 0402)                                                                                                                                                                                                                                                            |
| R4, R10, R11, C2, C3, C5, C6, C8, C9                                       | Supply Decoupling.                                                                                                                                                                                                                                                                                                                                                                                 | C2 = C5 = C9 = 100 pF (size 0402)<br>C3 = C6 = C8 = 0.01 $\mu$ F (size 0402)<br>R4 = R10 = R11 = 0 $\Omega$ (size 0402)                                                                                                                                                                                                          |
| C1, C7<br>R12, R13, R14, R15, C10, C11, C12, C13                           | Filtering VSUM.<br>Input Compensation. Provides essential HF compensation at the Input Pins INP1, INP2, IRF1, and IRF2.                                                                                                                                                                                                                                                                            | C1 = C7 = 0.01 $\mu$ F (size 0402)<br>R12 = R15 = 1 k $\Omega$ (size 0402)<br>R13 = R14 = 2 k $\Omega$ (size 0402)<br>C10 = C13 = 1 nF (size 0402)<br>C11 = C12 = 4.7 nF (size 0402)                                                                                                                                             |
| IREF, INPT                                                                 | Input Interface. The test board is configured to accept current through the SMA connectors labeled INP1 and INP2. Through-holes are provided to connect photodiodes in place of the INP1 and INP2 SMAs for optical interfacing. By removing R28 (R29 for INP2), a second current can be applied to the IRF1 (IRF2 for INP2) input (also SMA) for evaluating the ADL5310 in log ratio applications. | IREF = INPT = installed                                                                                                                                                                                                                                                                                                          |
| J1, J2                                                                     | SC-Style Photodiode. Provides for the direct mounting of SC-style photodiodes.                                                                                                                                                                                                                                                                                                                     | J1 = J2 = open                                                                                                                                                                                                                                                                                                                   |

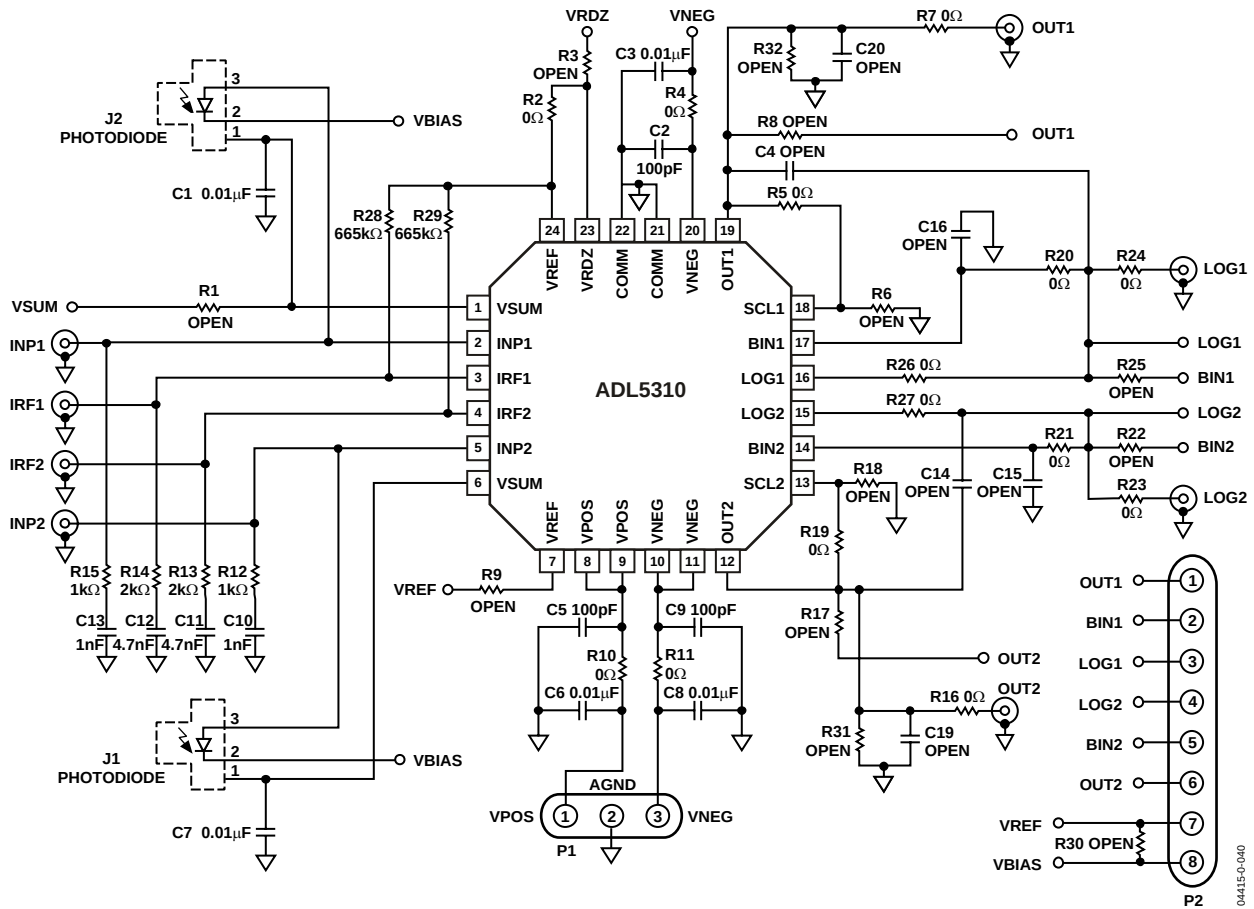


Figure 40. Evaluation Board Schematic

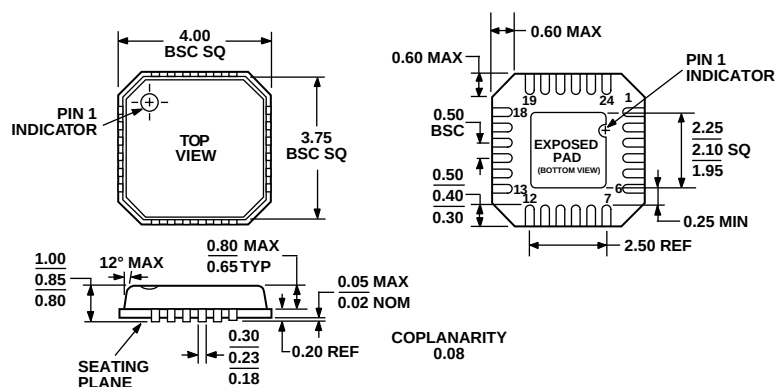


*Figure 41. Component-Side Layout*



Figure 42. Component-Side Silkscreen

## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-220-VGGD-2

Figure 43. 24-Lead Lead Frame Chip Scale Package [LFCSP]

4 mm × 4 mm Body

(CP-24-1)

Dimensions shown in millimeters

## ORDERING GUIDE

| Model            | Temperature Range | Package Description | Package Outline | Branding <sup>1</sup> |
|------------------|-------------------|---------------------|-----------------|-----------------------|
| ADL5310ACP-R2    | −40°C to +85°C    | 24-Lead LFCSP       | CP-24-1         | JQA                   |
| ADL5310ACP-REEL7 | −40°C to +85°C    | 24-Lead LFCSP       | CP-24-1         | JQA                   |
| ADL5310-EVAL     |                   | Evaluation Board    |                 |                       |

<sup>1</sup> Branding is as follows:

Line 1 — JQA

Line 2 — Lot Code

Line 3 — (Date Code) Date Code is in YYWW format